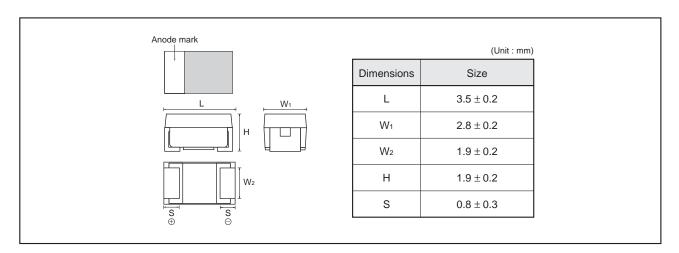
# Chip tantalum capacitors (Fail-safe open structure type)

TCFG Series B Case Datasheet

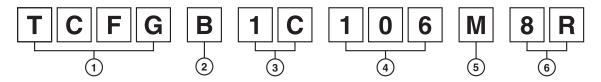
#### Features

- 1) Open structure built in for superior flame retardance characteristics.
- 2) Advanced wire bonding technology enable to make compact packages.
- 3) Eco-friendly halogen-free products.
- 4) Screening by thermal shock.

#### Dimensions



#### ●Part No. Explanation



- 1 Series name TCFG
- (2) Case style

B: 3528-21 (1411) size

3 Rated voltage

Rated voltage (V)	4	6.3	10	16	20	25
CODE	0G	0J	1A	1C	1D	1E

(4) Nominal capacitance

Nominal capacitance in pF in 3 digits: 2 significant figures followed by the figure representing the number of 0's.

(5) Capacitance tolerance

 $M:\pm 20\%$ 

6 Taping

8 : Reel width : 8mm

R: Positive electrode on the side opposite to sprocket hole

<sup>\*</sup>This specification has possibility of charge, due to underdevelopment product. Please ask for latest specification to our sales.

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#### ●Rated table

Capacitance		Rated voltage (V.DC)											
(μF)	4	6.3	10	16	20	25							
3.3 (335)				В		В							
4.7 (475)				В		В							
10 (106)				В	В								
15 (156)				В									
22 (226)		В	В	В									
33 (336)		В	В	В									
47 (476)		В	В										
100 (107)	В	В	В										
220 (227)	В	В											
330 (337)	☆B												

Remark) Case size codes (B) in the above show products line-up.

☆ Under development

# Marking

The indications listed below should be given on the surface of a capacitor.

(1) Polarity : The polarity should be shown by □ bar. (on the anode side)

(2) Rated DC voltage: A voltage code is shown as below table.
(3) Capacitance: A capacitance code is shown as below table.

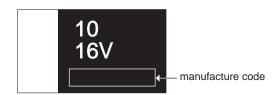
Visual typical example

voltage code and capacitance code are variable with parts number.

[B case]

EX.)  $\frac{10}{(1)} \frac{16V}{(2)}$ 

(1) capacitance (2) voltage



# Characteristics

Item				Pe	erforn	nance		Test conditions (based on JIS C5101-1 and JIS C5101-3)						
Operating Temp	perature	–55 °C	to +1	125 °	С			Vo	ceeds +85°C					
Maximum operatin with no voltage de		+85 °C												
Rated Voltage (	V.DC)	4 6.3	10	16	20	25		at	85°C					
Category Voltag	ge (V.DC)	2.5 4	6.3	10	13	16		at	125°C					
Surge Voltage		5.0 8	13	20	26	32		at	85°C					
DC leakage cur	Shall be satisfied the value on "Standard list"								As per 4.9 JIS C 5101-1 As per 4.5.1 JIS C 5101-3 Voltage: Rated voltage for 1 min					
Capacitance tol	Shall be ±20%	e satis	sfied	allowa	ance	range.	As Me Me	As per 4.7 JIS C 5101-1 As per 4.5.2 JIS C 5101-3 Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms, +1.5V.DC Measuring circuit : DC Equivalent series circu						
Tangent of loss (Df, tanδ)	angle	Shall be	e satis	sfied	the va	alue d	on "Standard list"	As per 4.8 JIS C 5101-1 As per 4.5.3 JIS C 5101-3 Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms, +1.5V Measuring circuit : DC Equivalent :						
Impedance						on "Standard list"	As per 4.10 JIS C 5101-1 As per 4.5.4 JIS C 5101-3 Measuring frequency : 100±10kHz Measuring voltage : 0.5Vrms or less Measuring circuit : DC Equivalent series							
Resistance to soldering heat	Appearance	There should be no significant abnormality. The indications should be clear.								4 JIS C 5101-1 3 JIS C 5101-3				
	L.C	$ \begin{array}{llllllllllllllllllllllllllllllllllll$						Dip in the solder bath  Solder temp : 260±5°C  Duration : 5±0.5s  Repetition : 1  After the specimens, leave it at room temperature for over 24h and then measure the sample.						
	⊿C/C													
	tanδ	3.3 to 3 47 to 19 TCFGE TCFGE TCFGE	50μF 80G22 80J22 81A10	7M8 7M8	R R R	: Les : Les : Les : Les	s than initial limit s than 150% of initial limit							
Fail-Safe open u	ınit actuation	Within 320°C – 20s						Dip in the solder bath Solder temp : 320±5°C						
Temperature	Appearance	There should be no significant abnormality.								6 JIS C 5101-1				
cycle	L.C	.C TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R TCFGB1E475M8R		R R	: Less than 200% of initial limit : Less than 200% of initial limit		Re	As per 4.10 JIS C 5101-3 Repetition : 5 cycles (1 cycle : stewithout discontinuation.			4)			
		Others					1	Temp. -55±3°C	Time 30±3min					
	⊿C/C	TCFGB0G227M8R	BR	: Within ±15% of initial value	1	2	Room temp.	3min. or less						
		TCFGE	30J22	7M8	R	: Witl	nin ±20% of initial value		3	125±2°C	30±3min			
		Others	, 1741	, i ivio		: Within $\pm 20\%$ of initial value : Within $\pm 10\%$ of initial value		4	Room temp.	3min. or less				
	tanδ	3.3 to 33µF 47 to 150µF TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R TCFGB1C336M8R  : Less than 150% of initial limit : Less than 200% of initial limit : Less than 200% of initial limit : Less than 150% of initial limit												



Ito	em		Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)
Moisture resistance	Appearance	There should be no s The indications should	ignificant abnormality. d be clear.	As per 4.22 JIS C 5101-1 As per 4.12 JIS C 5101-3
	L.C	TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R TCFGB1E475M8R Others	: Less than 150% of initial limit : Less than 200% of initial limit : Less than 200% of initial limit : Less than 150% of initial limit : Less than initial limit	After leaving the sample under such atmospheric condition that the temperature and humidity are 40±2°C and 90 to 95%RH, respectively, for 500±12h level it at room temperature for over 24h and then measure the sample.
	⊿C/C	TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R Others	: Within $\pm 15\%$ of initial value : Within $\pm 20\%$ of initial value : Within $\pm 20\%$ of initial value : Within $\pm 10\%$ of initial value	
	tanδ	3.3 to 33µF 47 to 150µF TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R TCFGB1C336M8R	: Less than initial limit : Less than 150% of initial limit : Less than 150% of initial limit : Less than 200% of initial limit : Less than 200% of initial limit : Less than 150% of initial limit	
Temperature	Temp.	−55°C		As per 4.29 JIS C 5101-1
Stability	⊿C/C	TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R Others	: Within 0/-15% of initial value : Within 0/-30% of initial value : Within 0/-30% of initial value : Within 0/-12% of initial value	As per 4.13 JIS C 5101-3
	tanδ	Shall be satisfied the	value on Table5	
	L.C		_	
	Temp.	+85°C		
	⊿C/C	TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R Others	: Within +12/0% of initial value : Within +15/0% of initial value : Within +15/0% of initial value : Within +10/0% of initial value	
	tanδ	Shall be satisfied the	value on Table5	
	L.C	Less than 1000% of i	ntial limit	
	Temp.	+125°C		
	⊿C/C	TCFGB0J227M8R TCFGB1A107M8R TCFGB1C336M8R Others	: Within +20/0% of initial value : Within +20/0% of initial value : Within +20/0% of initial value : Within +15/0% of initial value	
	tanδ	Shall be satisfied the	value on Table5	
	L.C	Less than 1250% of i	nitial limit	
Surge Voltage	Appearance	There should be no s The indications shoul		As per 4.26 JIS C 5101-1 As per 4.14 JIS C 5101-3
	L.C	TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R TCFGB1E475M8R Others	: Less than 150% of initial limit : Less than 200% of initial limit : Less than 200% of initial limit : Less than 150% of initial limit : Less than initial limit	Apply the specified surge voltage via the serial resistance of $1 \text{k}\Omega$ every $5 \pm 0.5 \text{min}$ . for $30 \pm 5$ s. each time in the atmospheric condition of $85 \pm 2^{\circ}\text{C}$ . Repeat this procedure 1,000 times. After the specimens, leave it at room temperature
	⊿C/C	TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R Others	: Within $\pm 15\%$ of initial value : Within $\pm 20\%$ of initial value : Within $\pm 20\%$ of initial value : Within $\pm 10\%$ of initial value	for over 24h and then measure the sample.
	tanδ	3.3 to 33µF 47 to 150µF TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R TCFGB1C336M8R	: Less than initial limit : Less than 150% of initial limit : Less than 200% of initial limit : Less than 200% of initial limit : Less than 200% of initial limit : Less than 150% of initial limit	



ŀ	tem	Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)					
Loading at High temperature	Appearance	There should be no significant abnormality. The indications should be clear.	As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3 After applying the rated voltage for 2000+72/0h					
	L.C	TCFGB0G227M8R TCFGB0J227M8R TCFGB1A107M8R TCFGB1E475M8R Others  1 Less than 200% of initial limit 1 Less than 200% of initial limit 1 Less than 200% of initial limit 1 Less than 150% of initial limit 1 Less than 150% of initial limit 1 Less than initial limit	without discontinuation via the serial resistance of 3Ω or less at a temperature of 85±2°C, leave the sample at room temperature/humidity for 1 to 2h and measure the value.  After the specimens, leave it at room temperature for over 24h and then measure the sample.					
	⊿C/C							
	tanδ	3.3 to 33µF : Less than initial limit : Less than 150% of initial limit : Less than 200% of initial limit : Less than 150% of initial limit : Less than 150% of initial limit						
Terminal	Capacitance	The measured value should be stable.	As per 4.35 JIS C 5101-1					
Strength	Appearance	There should be no significant abnormality.	As per 4.9 JIS C 5101-3 A force is applied to the terminal until it bends to 1mm and by a prescribed tool maintain the condition for 5s. (See the figure below.)  (Unit: mm)					
			F (Apply force)					
			Thickness 1.6mm					
Adhesiveness		The terminal should not come off.	As per 4.34 JIS C 5101-1 As per 4.8 JIS C 5101-3 Apply force of 5N in the two directions shown in the figure below for 10±1s after mounting the termina on a circuit board.					
			Apply force a circuit board					
Dimensions		Be based on "External dimensions"	Measure using a caliper of JIS B 7505 Class 2 or higher grade.					
Resistance to	solvents	The indication should be clear.	As per 4.32 JIS C 5101-1 As per 4.18 JIS C 5101-3 Dip in the isopropyl alcohol for 30±5s, at room temperature.					
Solderability		3/4 or more surface area of the solder coated terminal dipped in the soldering bath should be covered with the new solder.	As per 4.15.2 JIS C 5101-1 As per 4.7 JIS C 5101-3 Dip speed = 25±2.5mm/s Pre-treatment (accelerated aging) : Leave the sample on the boiling distilled water for 1h. Solder temp.: 245±5°C Duration : 3±0.5s Solder : M705 Flux : Rosin 25%, IPA 75%					
Vibration	Capacitance	Measure value should not fluctuate during the measurement.	As per 4.17 JIS C 5101-1 Frequency : 10 to 55 to 10Hz/min.					
	Appearance	There should be no significant abnormality.	Amplitude: 1.5mm Time: 2h each in X and Y directions Mounting: The terminal is soldered on a print circuit board.					

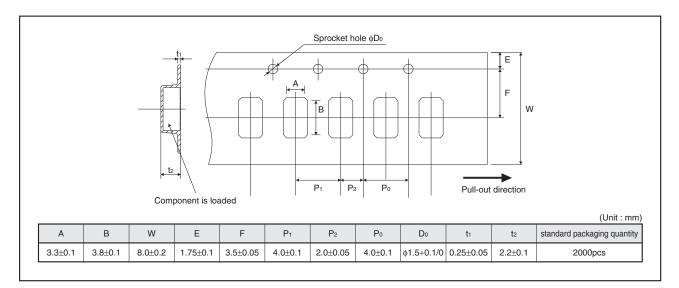
# ●Standard products list

Part No.	Rated voltage 85°C	Category voltage 125°C	Surge voltage 85°C	Cap. 120Hz	Tolerance	Leakage current 25°C	Df 120H (%)			Impedance 100kHz
	(V)	(V)	(V)	(μF)	(%)	1WV.60s (μA)	–55°C	25°C 85°C	125°C	(Ω)
TCFG B 0G 107 M8R	4	2.5	5	100	± 20	4.0	30	12	16	1.6
TCFG B 0G 227 M8R	4	2.5	5	220	± 20	8.8	40	20	30	1.3
* TCFG B 0G 337 M8R	4	2.5	5	330	± 20	66	60	30	45	1.3
TCFG B 0J 226 M8R	6.3	4	8	22	± 20	1.4	12	8	10	2.5
TCFG B 0J 336 M8R	6.3	4	8	33	± 20	2.1	12	8	10	2.0
TCFG B 0J 476 M8R	6.3	4	8	47	± 20	3.0	14	10	12	1.9
TCFG B 0J 107 M8R	6.3	4	8	100	± 20	6.3	30	12	16	1.5
TCFG B 0J 227 M8R	6.3	4	8	220	± 20	70	60	30	45	1.3
TCFG B 1A 226 M8R	10	6.3	13	22	± 20	2.2	12	8	10	2.0
TCFG B 1A 336 M8R	10	6.3	13	33	± 20	3.3	14	10	12	1.9
TCFG B 1A 476 M8R	10	6.3	13	47	± 20	4.7	14	10	12	1.6
TCFG B 1A 107 M8R	10	6.3	13	100	± 20	20	40	20	30	1.5
TCFG B 1C 335 M8R	16	10	20	3.3	± 20	0.5	10	6	8	4.2
TCFG B 1C 475 M8R	16	10	20	4.7	± 20	0.8	10	6	8	3.0
TCFG B 1C 106 M8R	16	10	20	10	± 20	1.6	10	6	8	2.5
TCFG B 1C 156 M8R	16	10	20	15	± 20	2.4	10	6	8	2.0
TCFG B 1C 226 M8R	16	10	20	22	± 20	3.5	10	6	8	1.9
TCFG B 1C 336 M8R	16	10	20	33	± 20	5.3	16	14	16	1.9
TCFG B 1D 106 M8R	20	13	26	10	± 20	2.0	12	8	10	15.0
TCFG B 1E 335 M8R	25	16	32	3.3	± 20	0.83	10	6	8	4.2
TCFG B 1E 475 M8R	25	16	32	4.7	± 20	1.2	10	6	8	3.0

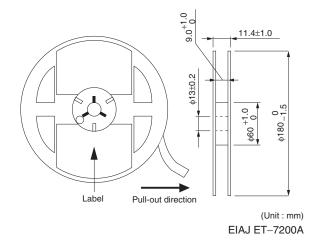
<sup>\* =</sup> Under development

TCFG Series B Case Datasheet

# Packaging specifications



#### •Reel dimensions



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